

Comlinear CLC111 Ultra-High Slew Rate, Closed-Loop Buffer

General Description

The Comlinear CLC111 is a high-performance, closed-loop, monolithic buffer designed for applications requiring very highfrequency signals. The CLC111's high performance includes an extremely fast 800MHz small signal bandwidth $(0.5V_{pp})$ and an ultra high (3500V/µs) slew rate while requiring only 10.5mA quiescent current. Signal fidelity is maintained with low harmonic distortion (-62dBc 2nd and 3rd harmonics at 20MHz). These performance characteristics are for a demanding 100Ω load.

Featuring a patented closed-loop design, the CLC111 offers nearly ideal unity-gain (0.996) with very low (1.4 Ω) output impedance. The CLC111 is ideally suited for buffering video signals with its 0.15%/ 0.04° differential gain and phase performance at 4.43MHz. Power sensitive applications will benefit from the CLC111's excellent performance on reduced or single supply voltages.

Constructed using an advanced, complementary bipolar process and Comlinear's proven high-performance architectures, the CLC111 is available in several versions to meet a variety of requirements.

CLC111AJP	-40°C to +85°C	8-pin Plastic DIP
CLC111AJE	-40°C to +85°C	8-pin Plastic SOIC
CLC111A8B	-55°C to +125°C	8-pin hermetic CERDIP,
		MIL-STD-883, Level B
CLC111ALC	-40°C to +85°C	dice
CLC111AMC	-55°C to +125°C	dice qualified to Method 5008,
		MIL-STD-883. Level B

Contact factory for other packages and DESC SMD number.

Features

- Very wideband (800MHz)
- Ultra-high (3500V/µs) slew rate
- Very low output impedance (1.4Ω)
- Low (-62dBc) 2nd/3rd harmonics @ 20MHz
- 60mA output current (±5 supplies)
- Single supply operation (0 to 3V supply min.)
- Evaluation boards and Spice models

Applications

- Video switch buffers
- Test point drivers
- High frequency active filters
- Wideband DC clamping buffer
- High-speed peak detector circuits



+V_{cc} 1 NC [2 Pinout **DIP & SOIC** NC 3 V_{in} 4



Itra-High Slew Rate, Closed-Loop Buffer mlinear CL

8 Vout

7 NC

6 NC $-V_{EE}$

5

PARAMETER	CONDITIONS	TYP	MIN ANI	D MAX RA	TINGS	UNITS	SYMBOL
Ambient Temperature	CLC109AJ/AI	+25°C	-40°C	+25°C	+85°C		
	CLC109A8/AM/AL	+25°C	-55°C	+25°C	+125°C		
REQUENCY RESPONSE							
small signal bandwidth	$V_{out} < 0.5 V_{pp}$	800	400	400	300	MHz	SSBW
5	$V_{out} < 4.0 V_{pp}$	450	250	250	200	MHz	LSBW
gain flatness1	$V_{out} < 0.5 V_{pp}$						-
flatness	DC-50MHz	0.02	±0.1	±0.1	±0.2	dB	GFL
peaking	DC-200MHz	0.1	1.0	0.5	0.5	dB	GFPH
rolloff	DC-200MHz	0.1	0.8	0.8	1.2	dB	GFRH
lifferential gain	4.43MHz, 150 Ω load	0.15	0.4	0.25	0.25	%	DG
lifferential phase	4.43MHz, 150 Ω load	0.04	0.08	0.08	0.08	0	DP
IME DOMAIN RESPONSE							
rise and fall time	0.5V step	0.6	0.8	0.8	1.1	ns	TRS
	4.0V step	1.0	1.4	1.4	1.7	ns	TRL
settling time to ±0.1%	2.0V step	16	20	20	20	ns	TS
overshoot	4V step	0	8	5	5	%	OS1
slew rate	4V step	3500	2700	2700	2300	V/µsec	SR
DISTORTION AND NOISE PER	FORMANCE						
2nd harmonic distortion	2V _{pp} , 20MHz	-62	-47	-50	-50	dBc	HD2
3rd harmonic distortion	2V _{pp} , 20MHz	-62	-55	-55	-52	dBc	HD3
equivalent output noise	2 vpp, 2011112	02	00	00	02	abo	1120
voltage	>1MHz	4.0	4.8	4.8	5.3	nV/√Hz	VN
current	>1MHz	1.6	4.0	3.0	3.0	pA/√Hz	ICN
TATIC DC PERFORMANCE							
small signal gain	no load	0.996	0.994	0.994	0.992	V/V	GA1
Sinali Signal gain	100Ω load	0.98	0.96	0.97	0.97	V/V	GA2
output resistance	DC	1.4	3.0	2.0	2.0	Ω	RO
*output offset voltage	20	2	17	9	9	mV	VIO
average temperature coe	officient	±30	±100	5	±50	μV/°C	DVIO
input bias current		5	30	15	15	μΑ	IBN
average temperature coe	efficient	50	±187		±100	nA/°C	DIBN
power supply rejection ratio		-52	-48	-48	-46	dB	PSRR
supply current	no load	10.5	12	12	12	mA	ICC
ISCELLANEOUS PERFORM							
integral endpoint linearity	±2V, full scale	0.2	1.0	0.5	0.5	%	ILIN
input resistance		1	0.3	0.5	1	MΩ	RIN
nput capacitance	CERDIP	2.5	3.5	3.5	3.5	pF	CIN
	Plastic DIP	1.25	2.0	2.0	2.0	pF	CIN
output voltage range	no load	3.9	3.5	3.6	3.6	V	VO
Supar voltage range	$R_L=100\Omega$	3.5	+3.1,-2.5	3.0	3.0	V	VOL
	$R_{L} = 100\Omega, 0^{\circ}C$	0.0	±3.1,-2.5	0.2	0.2	V	VOL
utput current	··(−100≥2, 0 O	60	50,25	50	40	mA	IO
	0° - 70°C		50,25	50	50	mA	10

Min/max ratings are based on product characterization and simulation. Individual parameters are tested as noted. Outgoing quality levels are determined from tested parameters.

Absolute Maximum Rat	ings	Miscellaneous Ratings
V _{cc} I _{out} output is short circuit protected to ground, but maximum reliability will be maintained if I _{out} does not exceed input voltage maximum junction temperature operating temperature range AJ/AI A8/AM/AL storage temperature range lead temperature (soldering 10 sec)	±7.0V 96mA ±V _{oc} +175°C -40°C to +85°C -55°C to +125°C -55°C to +125°C -65°C to +150°C +300°C	Notes: * AJ,AI : 100% tested at +25°C, sample +85°C. † AJ : Sample tested at +25°C. † AI : 100% tested at +25°C. * A8 : 100% tested at +25°C, -55°C, +125°C † A8 : 100% tested at +25°C, sample at -55°C, +125°C † A8 : 100% tested at +25°C, sample at -55°C, +125°C. * AL,AM : 100% wafer probe tested at +25°C to +25°C specifications. (note 1) : Gain flatness tests are performed from 0.1MHz

Single Supply Elect	rical Characteristic	CS (V _{cc} =+3V o	or V _{CC} =+5V,	$-V_{EE}=0V$, $T_{A}=+25$ °C, $R_{L}=100\Omega$, unless noted)
PARAMETERS	CONDITIONS	V _{CC} =3V	V _{CC} =5V	UNITS
FREQUENCY DOMAIN RESPONSE				
-3dB bandwidth	$V_{out} < 0.5V_{pp}$ $V_{out} < 2.0V_{pp}$	120	300 210	MHz MHz
gain flatness	$V_{out} < 0.5 V_{pp}$			
flatness	DC to 30MHz	0.5	0.1	dB
peaking rolloff	DC to 200MHz DC to 60MHz	0	0	dB dB
			0.20	
rise and fall time	0.5V step	3.9	1.2	ll ns
	2.0V step	5.8	1.5	l ns
overshoot	1.0V step	3	3	%
slew rate	0.5V step	260	425	⁷⁶ V/μs
DISTORTION AND NOISE R	ESPONSE			· · · · · · · · · · · · · · · · · · ·
2 nd harmonic distortion	0.5V _{pp} ,20MHz	-46		dBc
	1.0V _{pp} ,20MHz		-55	dBc
3 rd harmonic distortion	$0.5V_{pp}$,20MHz	-44		dBc
	1.0V _{pp} ,20MHz		-64	dBc
STATIC DC PERFORMANCE				
small-signal gain	AC-coupled	0.96	0.97	V/V
supply current	R _L = ∞	2.0	4.5	mA
MISCELLANEOUS PERFOR	MANCE			
output voltage range	$R_1 = \infty$	1.5	3.4	
	R_=100Ω	1.1	2.6	

Operation

The CLC111 is a low-power, very high-speed unity-gain buffer. It uses a closed-loop topology which allows for accuracy not usually found in high-speed open-loop buffers. A slew enhanced front end allows for low quiescent power while not sacrificing ac performance.

Single Supply Operation

Although the CLC111 is specified to operate from split $\pm 5V$ power supplies, there is no internal ground reference that prevents operation from a single voltage power supply. For single supply operation the input signal should be biased at a DC value of $\frac{1}{2}V_{cc}$. This can be accomplished by AC coupling and rebiasing as shown in Figure 1.

The above electrical specifications provide typical performance specifications for the CLC111 at 25°C while operating from a single +3V or a single +5V power supply.

Printed Circuit Layout and Supply Bypassing

As with any high-frequency device, a good PCB layout is required for optimum performance. This is especially important for a device as fast as the CLC111.

To minimize capacitive feedthrough, pins 2, 3, 6, and 7 should be connected to the ground plane, as shown in Figure 1. Input and output traces should be laid out as transmission lines with the appropriate termination resistors very near the CLC111. On a 0.065 inch epoxy PCB material, a 50Ω transmission line (commonly called stripline) can be constructed by using a trace width of 0.1" over a complete ground plane.

Figure 1 shows recommended power supply bypassing.

The ferrite beads are optional and are recommended only where additional isolation is needed from high-frequency (>400MHz) resonances in the power supply.



Figure 1: Recommended circuit & evaluation board schematic

Parasitic or load capacitance directly on the output of the CLC111 will introduce additional phase shift in the device. This phase shift can decrease phase margin and increase frequency response peaking. A small series resistor before the capacitance effectively decouples this effect. The graphs on the following page illustrate the required resistor value and the resulting performance vs. capacitance.

Precision buffed resistors (PRP8351 series from Precision Resistive Products), which have low parasitic reactances, were used to develop the data sheet specifications. Precision carbon composition resistors or standard spirallytrimmed RN55D metal film resistors will work, though they will cause a slight degradation of ac performance due to their reactive nature at high frequencies.

Evaluation Boards

Evaluation boards are available from Comlinear as part #730012 (DIP) and #730045 (SOIC). This board was used in the characterization of the device and provides optimal performance. Designers are encouraged to copy these printed circuit board layouts for their applications.

Typical Performance Characteristics ($T_A = +25^{\circ}C$, $V_{cc} = \pm 5V$, $R_L = 100\Omega$ unless specified)



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